

October 1987 Revised March 2002

CD4043BC • CD4044BC Quad 3-STATE NOR R/S Latches • Quad 3-STATE NAND R/S Latches

General Description

The CD4043BC are quad cross-couple 3-STATE CMOS NOR latches, and the CD4044BC are quad cross-couple 3-STATE CMOS NAND latches. Each latch has a separate Q output and individual SET and RESET inputs. There is a common 3-STATE ENABLE input for all four latches. A logic "1" on the ENABLE input connects the latch states to the Q outputs. A logic "0" on the ENABLE input disconnects the latch states from the Q outputs resulting in an open circuit condition on the Q output. The 3-STATE feature allows common bussing of the outputs.

Features

■ Wide supply voltage range: 3V to 15V

■ Low power: 100 nW (typ.)

■ High noise immunity: 0.45 V_{DD} (typ.)

- Separate SET and RESET inputs for each latch
- NOR and NAND configuration
- 3-STATE output with common output enable

Applications

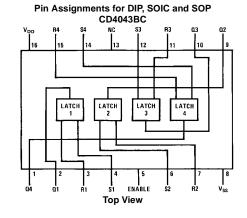
- Multiple bus storage
- Strobed register
- Four bits of independent storage with output enable
- · General digital logic

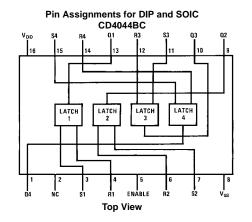
Ordering Code:

Order Number	Package Number	Package Description
CD4043BCM	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
CD4043BCN	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
CD4044BCM	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
CD4044BCSJ	M16D	16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
CD4044BCN	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

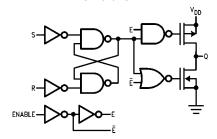
Connection Diagrams



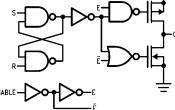


Block Diagrams

CD4043BC



CD4044BC



Truth Tables

CD4043BC

S	R	Е	Q
Х	Х	0	OC NC
0	0	1	NC
1	0	1	1
0	1	1	0
1	1	1	Δ

CD4044BC

S	R	E	Q
Х	Х	0	OC
1	1	1	NC
0	1	1	1
1	0	1	0
0	0	1	$\Delta\Delta$

OC = 3-STATE NC = No change X = Don't care $\Delta = Dominated by S = 1 input$ $\Delta\Delta = Dominated by R = 0 input$

Absolute Maximum Ratings(Note 1)

(Note 2)

 $\label{eq:Supply Voltage VDD} Supply Voltage (V_{DD}) & -0.5V \text{ to } +18V \\ \text{Input Voltage (V_{IN})} & -0.5V \text{ to } V_{DD} +0.5V \\ \end{cases}$

Storage Temperature Range (Ts) -65°C to +150°C

Power Dissipation (P_D)

Dual-In-Line 700 mW Small Outline 500 mW

Lead Temperature (T_L)

(Soldering, 10 seconds) 260°C

Recommended Operating Conditions

(Note 2)

 $\begin{array}{ll} \mbox{Supply Voltage (V_{DD})} & 3.0 \mbox{V to 15V} \\ \mbox{Input Voltage (V_{IN})} & 0 \mbox{ to V}_{DD} \mbox{ V} \end{array}$

Operating Temperature Range (T_A)

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed; they are not meant to imply that the devices should be operated at these limits. The tables of "Recommended Operating Conditions" and "Electrical Characteristics" provide conditions for actual device operation.

Note 2: $V_{SS} = 0V$ unless otherwise specified.

DC Electrical Characteristics (Note 2)

Cumbal	Parameter	Conditions	-55	–55°C		+25°C			+125°C	
Symbol		Conditions	Min	Max	Min	Тур	Max	Min	Max	Units
I _{DD}	Quiescent	$V_{DD} = 5V$, $V_{IN} = V_{DD}$ or V_{SS}		5		0.01	5		150	
	Device Current	$V_{DD} = 10V$, $V_{IN} = V_{DD}$ or V_{SS}		10		0.01	10		300	μΑ
		$V_{DD} = 15V$, $V_{IN} = V_{DD}$ or V_{SS}		20		0.02	20		600	
V _{OL}	LOW Level	$ I_{O} \le 1 \mu A, V_{IL} = 0V, V_{IH} = V_{DD}$								
	Output Voltage	$V_{DD} = 5.0V$		0.05		0	0.05		0.05	
		V _{DD} = 10V		0.05		0	0.05		0.05	V
		V _{DD} = 15V		0.05		0	0.05		0.05	
V _{OH}	HIGH Level	$ I_{O} \le 1 \mu A, V_{IL} = 0V, V_{IH} = V_{DD}$								
	Output Voltage	$V_{DD} = 5.0V$	4.95		4.95	5.0		4.95		
		V _{DD} = 10V	9.95		9.95	10		9.95		V
		V _{DD} = 15V	14.95		14.95	15		14.95		
V _{IL}	LOW Level	I _O ≤ 1 μA								
	Input Voltage	$V_{DD} = 5.0V, V_{O} = 0.5V \text{ or } 4.5V$		1.5		2.25	1.5		1.5	
		$V_{DD} = 10V, V_{O} = 1.0V \text{ or } 9.0V$		3.0		4.5	3.0		3.0	V
		$V_{DD} = 15V$, $V_{O} = 1.5V$ or $13.5V$		4.0		6.75	4.0		4.0	
V _{IH}	HIGH Level	I _O ≤ 1 μA								
	Input Voltage	$V_{DD} = 5.0V, V_{O} = 0.5V \text{ or } 4.5V$	3.5		3.5	2.75		3.5		
		$V_{DD} = 5.0V, V_{O} = 1.0V \text{ or } 9.0V$	7.0		7.0	5.5		7.0		V
		$V_{DD} = 15V, V_{O} = 1.5V \text{ or } 13.5V$	11		11	8.25		11		
I _{OL}	LOW Level	$V_{IL} = 0V$, $V_{IH} = V_{DD}$								
	Output Current	$V_{DD} = 5.0V, V_{O} = 0.4V$	0.64		0.51	1.0		0.36		
	(Note 3)	$V_{DD} = 10V, V_{O} = 0.5V$	1.6		1.3	2.6		0.9		mA
		$V_{DD} = 15V, V_{O} = 1.5V$	4.2		3.4	6.8		2.4		
I _{OH}	HIGH Level	$V_{IL} = 0V$, $V_{IH} = V_{DD}$								
	Output Current	$V_{DD} = 5.0V, V_{O} = 4.6V$	-0.64		-0.51	-0.4		-0.36		
	(Note 3)	$V_{DD} = 10V, V_{O} = 9.5V$	-1.6		-1.3	-1.0		-0.9		mA
		$V_{DD} = 15V, V_{O} = 13.5V$	-4.2		-3.4	-3.0		-2.4		
I _{IN}	Input Current	V _{DD} = 15V, V _{IN} = 0V		-0.1		-10.5	-0.1		-1.0	
		$V_{DD} = 15V, V_{IN} = 15V$		0.1		10.5	0.1		1.0	μΑ

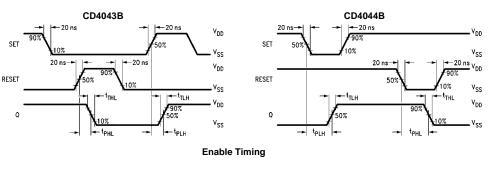
Note 3: I_{OH} and I_{OL} are tested one output at a time.

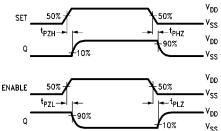
AC Electrical Characteristics (Note 4) $T_A=25^{\circ}C,\,C_L=50\;\text{pF},\,R_L=200k,\,\text{input}\;t_f=t_f=20\;\text{ns, unless otherwise noted}$

Symbol	Parameter	Conditions	Min	Тур	Max	Units
t _{PLH} , t _{PHL}	Propagation Delay S or R to Q	V _{DD} = 5.0V		175	350	
		$V_{DD} = 10V$		75	175	ns
		$V_{DD} = 15V$		60	120	
t _{PZH} , t _{PHZ}	Propagation Delay Enable to Q (HIGH)	$V_{DD} = 5.0V$		115	230	
		$V_{DD} = 10V$		55	110	ns
		V _{DD} = 15V		40	80	
t _{PZL} , t _{PLZ}	Propagation Delay Enable to Q (LOW)	$V_{DD} = 5.0V$		100	200	
		$V_{DD} = 10V$		50	100	ns
		V _{DD} = 15V		40	80	
t _{THL} , t _{TLH}	Transition Time	$V_{DD} = 5.0V$		100	200	
		$V_{DD} = 10V$		50	100	ns
		V _{DD} = 15V		40	80	
t _{WO}	Minimum SET or RESET Pulse Width	$V_{DD} = 5.0V$		80	160	
		$V_{DD} = 10V$		40	80	ns
		V _{DD} = 15V		20	40	
C _{IN}	Input Capacitance			5.0	7.5	pF

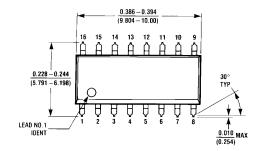
Note 4: AC Parameters are guaranteed by DC correlated testing.

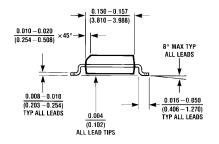
Timing Waveforms

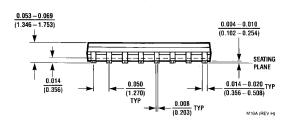




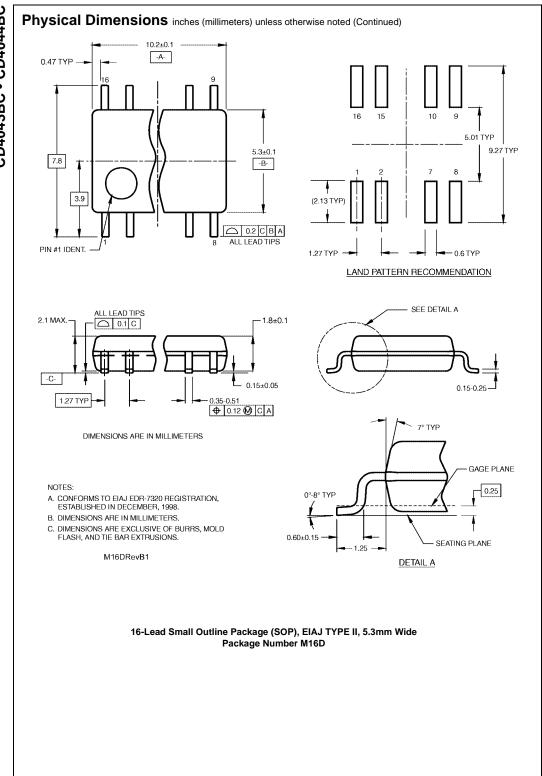


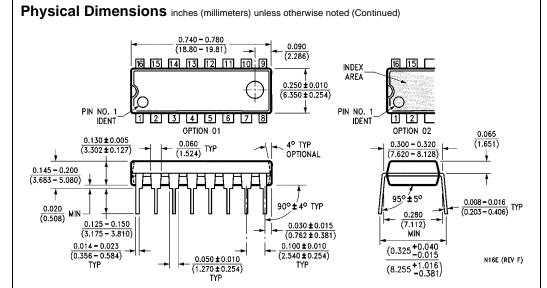






16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Package Number M16A





16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N16E

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